

Application/Control No.	Applicant(s)/Paten Reexamination	t under
10/519,981	FUJITA ET AL.	
Examiner	Art Unit	
Joseph Pop	1703	

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated PALM Inventor Search	2/24/2009	JR		